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## Manipulating the Raman scattering rotation via magnetic field in an MoS<sub>2</sub> monolayer†

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Magneto-optical effects, which originate from the interactions between light and magnetism, have provided an important way to characterize magnetic materials and hosted abundant applications, such as light modulators, magnetic field sensors, and high-density data storage. However, such effects are too weak to be detected in non-magnetic materials due to the absence of spin degree of freedom. Here, we demonstrated that applying a perpendicular magnetic field can produce a colossal Raman scattering rotation in non-magnetic MoS<sub>2</sub>, for A-mode representing the out-of-plane breathing vibration. Our experimental results show that linearly polarized scattering light is rotated by  $\mp 125^\circ$ , more apparent than the valley Zeeman splitting effect ( $\mp 1.2$  meV) under the same experimental conditions ( $\pm 5$  T), near room temperature. A detailed and systematic analysis on the polarization-resolved magnetic field-dependent micro-zone Raman intensity offers a feasible way to manipulate the inelastically scattered light via a magnetic technique. This explored phenomenology and physical mechanism arouse a new ramification of probing burgeoning magneto-optical effects in the field of two-dimensional laminar materials.

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### Introduction

Two-dimensional (2D) materials have received considerable attention and interest since the successful isolation of graphene for the first time.<sup>1</sup> In recent years, transition metal dichalcogenides (TMDCs) have become the flagship materials after graphene. The considerable extraordinary properties of TMDCs include the direct bandgap in visible and near-infrared wavelengths, suitable for exploring their potential in optoelectronics,<sup>2</sup> and the fascinating mechanism concerning the spin and the valley pseudospin, enabling unprecedented electronic devices or techniques.<sup>3</sup> However, due to the limited thickness of such van der Waals (vdWs) materials, particularly for the monolayer, it is difficult to characterize the intrinsic properties

experimentally, which is inappropriate to the rapid development in this field.

Raman spectroscopy primarily focuses on the measurement of the inelastic scattering radiation generated from collective quasi-particle excitations.<sup>4</sup> The crystal structure, atomic vibrating mode, and polarization angles between the incident light and detected light all have significant impacts on the intensity of Raman modes, making it an exceedingly effective technique for studying the crystal property and the property variation attributed from external perturbations. As reported in literature, Raman spectroscopy has been performed to examine the changes in the material property influenced by temperature,<sup>5,6</sup> humidity,<sup>7</sup> strain,<sup>8</sup> externally applied electric field,<sup>9</sup> or magnetic field.<sup>10,11</sup> Along with the research upsurge in 2D magnets, Raman spectroscopy<sup>12–17</sup> has been broadly adopted to characterize the magnetic property based on the surface sensitivity and remarkable magneto-optical effects. The successful applications of inelastic light scattering in such magnets has provided important information in studying magnetic impurity light scattering,<sup>18,19</sup> defect magnetism,<sup>20</sup> spin-flip inelastically scattered light in diluted magnetic semiconductors,<sup>21,22</sup> and lattice vibrations in colossal magneto-resistive materials.<sup>23–25</sup> However, in most of the fabricated 2D vdWs materials, the absence of spin moments can only provide limited electronic or structural information relying solely on Raman techniques.

Molybdenum disulfide (MoS<sub>2</sub>), a representative 2D semiconductor in the TMDC family, has recently drawn extensive attention.<sup>26</sup> In laminar MoS<sub>2</sub>, the bulk crystals are formed by

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stacking covalently-bonded S–Mo–S sandwiched trilayers *via* relatively weak vdWs interactions. As the thickness is thinned from bulk to monolayer, on account of the 2D quantum confinement effect, the bandgap of MoS<sub>2</sub> will transfer from indirect to direct, with remarkable increase in the luminescence quantum efficiency.<sup>26,27</sup> Briefly, with the distinct crystal structure enabling the degenerate-but-inequivalent valleys,<sup>28–30</sup> remarkable photoluminescence (PL) in the visible frequency range<sup>26,27</sup> and appropriate Gibbs free energy for large-scale hydrogen production applications,<sup>31,32</sup> monolayer MoS<sub>2</sub> has offered considerable potential for the exploration of excellent electronic<sup>33,34</sup> and optoelectronic<sup>35–37</sup> devices. Herein, by performing polarization-resolved magneto-Raman spectroscopy measurements, we discovered a gigantic scattering rotation of A-mode in the Raman spectra obtained from MoS<sub>2</sub> monolayers in the presence of a perpendicular magnetic field. Although the well-known valley Zeeman splitting under the same conditions is quite weak as expected, the maximum Raman scattering feature rotation is about  $\mp 125^\circ$ , which has never been observed. This obvious magneto-optical effect originates from the symmetry breaking when the magnetic field is perpendicularly applied, particularly for the electron motion during the inelastically scattering process, which implies that the non-magnetic laminar materials can still exhibit an apparent response to the magnetic field. Thus, our study validates the magneto-Raman spectroscopy as a sensitive technique to characterize properties in quantum material systems, refines the microscopic inelastic scattering theory and demonstrates new avenues for modulating the optical signals based on the phonon polarity-related symmetry, providing a platform for the innovative magneto-optical devices and techniques based on 2D laminar materials, such as phonon lasers and nanomechanical oscillators.

## Results and discussion

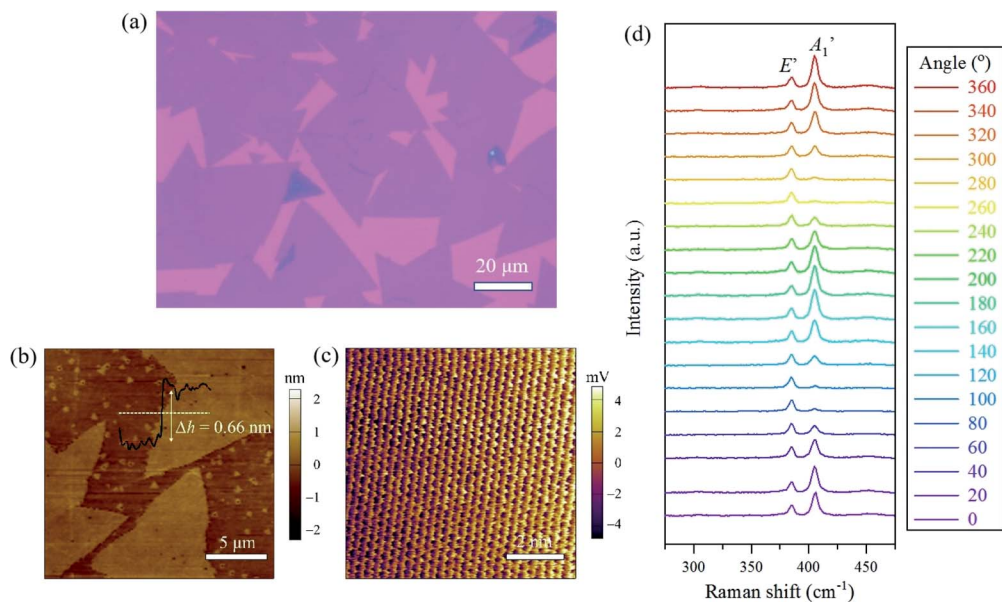
MoS<sub>2</sub> samples were synthesized directly on the surface of Si/SiO<sub>2</sub> substrates *via* the commonly used chemical vapor deposition (CVD) method.<sup>38,39</sup> From the optical microscopy image (Fig. 1a) and the atomic force microscope (AFM) topography image (Fig. 1b), we can see that most MoS<sub>2</sub> domains on Si/SiO<sub>2</sub> appear as triangles with the side length of  $28.1 \pm 12.8 \mu\text{m}$  (ESI Fig. S1†), obeying the symmetry of the hexagonal crystal lattice. The height profile along the MoS<sub>2</sub> triangular domain shows a terrace of  $\sim 0.66 \text{ nm}$ , as an indication of the monolayer. When imaged at a higher resolution, as shown in the lateral deflection signal obtained by AFM (Fig. 1c), the MoS<sub>2</sub> lattice possessing a honeycomb-like hexagonal arrangement of spots can be clearly resolved. This high-resolution AFM image was obtained *via* a conventional tip (TR400PSA) operating at ambient conditions, readily shown in the AFM lateral deflection images but only occasionally in the AFM topography images. It should be mentioned that the lattice-resolution image does not exhibit the accurate atomic-level resolution; on the contrary, the actual contact area between the scanned-cantilever and the MoS<sub>2</sub> sample surface is up to the order of  $10 \times 10 \text{ nm}^2$ ; however, the periodic stick-slip atomic-level frictional forces are adequate to

capture the lattice-level resolution, sufficiently enough to determine the crystallographic orientation.<sup>40,41</sup>

Bulk MoS<sub>2</sub> belongs to the space group of  $D_{6h}$ , possessing a dozen of vibration modes at the high-symmetric  $\Gamma$  point,<sup>8</sup> four of which are first-order active, named in terms of the vibration mode symmetry, as  $E_{2g}^2$ ,  $E_{1g}$ ,  $E_{2g}^1$ , and  $A_{1g}$ . The  $E_{1g}$  mode is forbidden, while  $E_{2g}^1$  and  $A_{1g}$  modes are allowed when the incident excitation light propagates along the MoS<sub>2</sub>  $c$ -axis as the light path configuration used in our experiments. The low-wavenumber  $E_{2g}^2$  mode is not in view in this study. For the MoS<sub>2</sub> monolayer, the  $A$ - and  $E$ -mode symmetries will become  $A'_1$  and  $E'$ . Besides, the monolayer nature of MoS<sub>2</sub> samples can be easily identified by distinguishing the peak position interval between the  $A'_1$  and  $E'$  modes, which is prevalently adopted to determine the thickness of ultrathin MoS<sub>2</sub> nanoflakes<sup>42</sup> and confirmed by PL spectrum as a supplement.<sup>26,27</sup> As a direct-gap semiconductor, the PL spectrum of the MoS<sub>2</sub> monolayer on Si/SiO<sub>2</sub> exhibits a strong excitonic emission (ESI, Fig. S2†).

The schematic of the experimental set-up for micro-zone Raman signal collection under the magnetic fields is shown in Fig. 2a. From the top view, the linear polarizer in front of the notch filter enables the collection of the polarization-resolved optical signal. During the process of signal collection, we began along the parallel direction ( $\varphi = 0^\circ$ ) and continuously rotated the polarizer with the step of  $10^\circ$  until a cycle of  $360^\circ$  was finished. For compactness and simplicity, only 19 measured Raman spectra, along with the polarization angles between the incident light and the scattered radiation with the step of  $20^\circ$  are plotted in Fig. 1d. Two dominant peaks at  $384$  and  $404 \text{ cm}^{-1}$ , corresponding to the  $E'$  and  $A'_1$  modes, are clearly observed. As shown in this series of Raman spectra (Fig. 1d), the breathing mode along the  $c$ -axis of S atoms ( $A'_1$ ) exhibits a noteworthy polar dependence and can be negligible when the polarization angle reaches  $90^\circ$ , where the polarized incident light and the scattered light are orthogonal. In comparison, the intensities of the in-plane shearing motion ( $E'$ ) vary very slightly. The polar behavior of these two modes, regardless of the MoS<sub>2</sub> crystalline orientation, only shows the relationship with the polarization angles between the incident and scattered lights when no magnetic field is applied (ESI, Fig. S3†), which can be easily understood by the optical selection rules based on the symmetry of MoS<sub>2</sub> Raman tensors (more discussion later).<sup>8</sup>

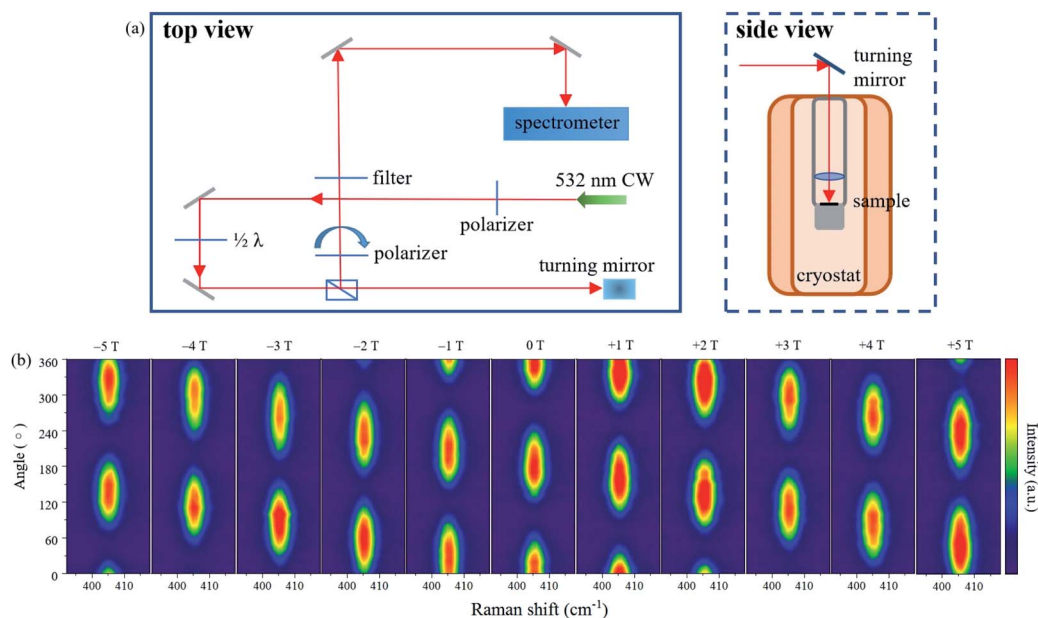
As depicted from the side view of the magneto-Raman measurement experimental set-up (Fig. 2a), a superconducting magnet (attoDRY2100, attocube) was used to maintain the perpendicular magnetic field of up to  $\pm 5 \text{ T}$ . In our experiments, the incident and scattered lights, and the direction of the magnetic field are all perpendicular to the surface of the MoS<sub>2</sub> sample, *viz* the  $c$ -plane. The positive magnetic field is defined as the upward direction. In the presence of magnetic field, the time-reversal symmetry breaking will induce the  $A'_1$  mode in the MoS<sub>2</sub> monolayer to be presented in the form of  $A'$ , while the  $E'$  mode remains unchanged. The Raman characteristic peak located at  $521 \text{ cm}^{-1}$  corresponding to the Si substrate is recorded as reference throughout the whole measurement process (ESI, Fig. S4†). Polarization-resolved Raman spectra through a full  $360^\circ$  were collected from the MoS<sub>2</sub> monolayer at selected



**Fig. 1** (a) Optical microscopy image of the MoS<sub>2</sub> monolayers synthesized on the Si/SiO<sub>2</sub> substrate. (b) AFM topography image of MoS<sub>2</sub> monolayers synthesized on the Si/SiO<sub>2</sub> substrate, together with the corresponding height analysis. (c) Magnified AFM lateral deflection image of MoS<sub>2</sub>, exhibiting the hexagonal lattice structure. (d) A series of Raman spectra of the MoS<sub>2</sub> monolayer, along with the polarization angles between the incident light and the scattered radiation.

magnetic fields. There exists no obvious difference in the frequency values of E' and A' modes no matter how the magnetic field strength changes. Since the E' mode remains constant and shows no direct relationship to the magnetic field under all polarization angle configurations, we mainly focus on the wavenumber ranging from 400 cm<sup>-1</sup> to 410 cm<sup>-1</sup> where the

A' mode is located. As shown in Fig. 2b, the A' mode exhibits a conspicuous response to the magnetic field. As the perpendicular magnetic field ranges from negative (-5 T) to positive (+5 T), the polar behavior of the A' mode shows a monotonous evolution. Polar plots of the E' and A' integrated intensities as a function of the polarization angles between the incident light



**Fig. 2** (a) A schematic of the experimental set-up for micro-zone magneto-Raman measurements. Positive magnetic field is defined as the upward direction. The excitation laser is a 532 nm continuous wave (CW) laser. (b) Polarization-dependence of Raman spectra corresponding to the monolayer MoS<sub>2</sub> A' mode, measured at selected magnetic fields; the corresponding value of the applied perpendicular magnetic field is labelled above each contour image.

and the scattered radiation (Fig. 3a–k) can reveal the evolution trend of the polar behavior of these two modes more clearly. The Raman scattering pattern shows a gigantic rotation with the changes in the magnetic field strength. The linearly polarized inelastically scattered light rotates by  $\sim \mp 125^\circ$  ( $\mp 2.2$  rad) when the perpendicular magnetic field reaches  $\pm 5$  T (Fig. 3l).

MoS<sub>2</sub> has a honeycomb-like crystal lattice structure.<sup>10</sup> The MoS<sub>2</sub> material possesses the point-group symmetry of  $D_{6h}$  in the bulk form and becomes  $D_{3d}$  in the bilayer form. The symmetry is further reduced to  $D_{3h}$  when the MoS<sub>2</sub> material decreases to monolayer, at which the center inversion symmetry is broken. The polarization dependence of the scattering intensity can be expressed as  $I_s \propto |e_i \chi e_s|^2$ , where  $e_i$  and  $e_s$  are the unit vectors describing the polarized states of the incident and scattered lights, respectively, and  $\chi$  is the Raman tensor. In this study, the polarization of the incident light is fixed along the horizontal direction, while that of the scattered light is selected with an angle  $\varphi$  to the horizontal by a polarizer,

$$e_i = \begin{pmatrix} 1 \\ 0 \\ 0 \end{pmatrix}, e_s = \begin{pmatrix} \cos\varphi \\ \sin\varphi \\ 0 \end{pmatrix}, \quad (1)$$

In consideration of

$$\chi_{E'(D_{3h})} = \begin{pmatrix} d & 0 & 0 \\ 0 & -d & 0 \\ 0 & 0 & 0 \end{pmatrix}, \chi_{A'_1(D_{3h})} = \begin{pmatrix} a & 0 & 0 \\ 0 & a & 0 \\ 0 & 0 & b \end{pmatrix}, \quad (2)$$

thus under zero field,  $E'$  and  $A'_1$  modes follow  $d^2$  and  $a^2 \cos^2 \varphi$  dependence, respectively, and are clearly demonstrated by our fitting results, as shown in Fig. 3f. Here,  $d$  and  $a$  are the elements of the Raman tensor, and the absolute value of these two does not matter. For the MoS<sub>2</sub> monolayer, when  $B//c$ -axis, the point-group symmetry of  $D_{3h}$  will be further reduced compared to that of  $C_{3h}$ . In general, in the presence of magnetic field, the time-reversal symmetry breaking can add an anti-

symmetric component to the A-mode Raman tensor, shown as  $A'$ , which can partly explain the rotation in the scattered light polarization,

$$\chi_{A'(C_{3h})} = \begin{pmatrix} a & c & 0 \\ -c & a & 0 \\ 0 & 0 & b \end{pmatrix}. \quad (3)$$

But it's unpredictable that this scattering rotation is remarkably large.<sup>43</sup>

The preliminary analysis indicates that the giant rotation of the  $A'$  polar pattern closely related to the magnetic field requires a systematic investigation into the Raman scattering process. From a microcosmic viewpoint, the Raman scattering process includes the absorption of photons to activate the system to an excited state, the excitation of phonons *via* electron–phonon interactions in the intermediate step accompanied by decaying to a low-energy virtual state, and the emission of photons to return to the ground state. It is reasonable that if the intermediate states of electrons are perturbed by magnetic field, which is externally applied perpendicular to the MoS<sub>2</sub>  $c$ -plane, the property of radiated phonons during the Raman scattering process will make a difference. The intensity of the Raman scattering signal strongly relies on the second-order electronic susceptibility  $\alpha$ , which can be expressed as a function of normal coordinates and external magnetic fields. The Lorentz force upon electrons induced from the magnetic field perpendicular to the sample  $c$ -plane will generate an additional transverse component to the in-plane electron motion. The behavior of the 2D electron motion can be described and quantified in the form of equations as

$$\begin{cases} \ddot{x} + \gamma \dot{x} + \omega_0^2 x + \frac{eB}{m} \dot{y} + \frac{e}{m} E e^{i\omega t} = 0 \\ \dot{y} + \gamma \dot{y} + \omega_0^2 y - \frac{eB}{m} \dot{x} = 0 \end{cases}, \quad (4)$$

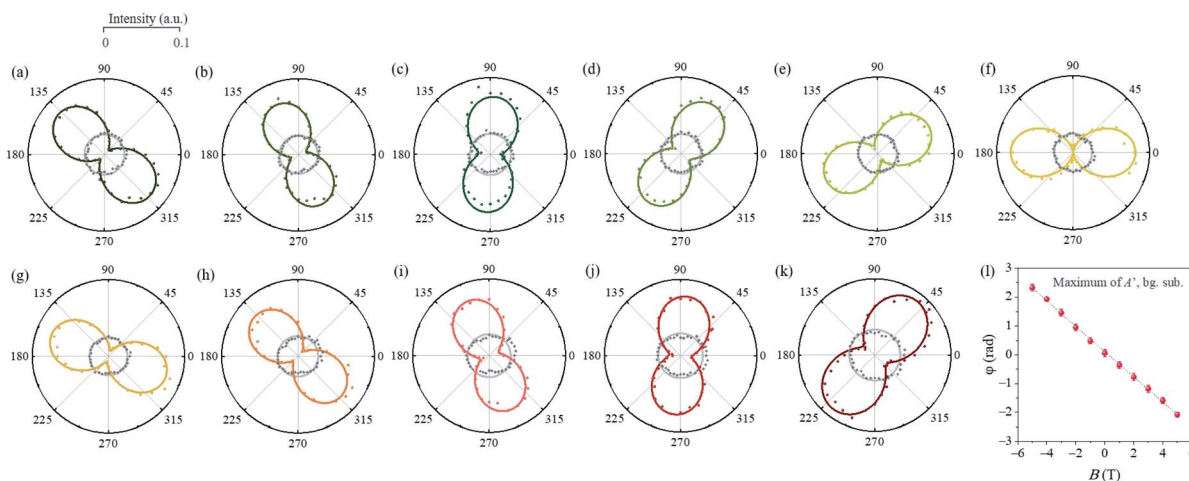


Fig. 3 Polar plots of the integrated intensities of  $E'$  and  $A'$  modes as a function of polarization angles between the incident light and the scattered radiation at  $B =$  (a)  $-5$  T, (b)  $-4$  T, (c)  $-3$  T, (d)  $-2$  T, (e)  $-1$  T, (f)  $0$  T, (g)  $+1$  T, (h)  $+2$  T, (i)  $+3$  T, (j)  $+4$  T, and (k)  $+5$  T. (l) The polarization angle where the maximum of  $A'$  mode lies *versus* the perpendicular magnetic field strength. Systematic error induced by Faraday effects or Faraday rotation has been considered and excluded.

where  $E$  and  $B$  are the electric field vector of the incident light normal to the  $c$ -plane and the magnetic field, respectively. The rest of the parameters,  $e$ ,  $m$ ,  $\gamma$ ,  $\omega$ , and  $\omega_0$  are the charge, effective mass, scattering rate, incident light frequency, and excited electron restoring frequency, respectively.

Taking the Lorentz force into consideration, the dependence of the second-order electronic susceptibility on the magnetic field,  $\alpha(B)$ , can be derived based on the expressions provided in eqn (4) as

$$\begin{cases} \alpha_{xx}(B) = \alpha_{yy}(B) = -\frac{e\chi}{E} \alpha \frac{B_0}{B_0^2 + B^2} \\ \alpha_{xy}(B) = \alpha_{yx}(B) = -\frac{e\gamma}{E} \alpha \frac{B}{B_0^2 + B^2} \end{cases}, B_0 = \frac{m\gamma}{e} \left( 1 - i \frac{\omega_0^2 - \omega^2}{\omega\gamma} \right) \quad (5)$$

where  $B_0$  can be regarded as a resonant magnetic field where the influence on the polarization-resolved scattering light caused by the applied magnetic field reaches the peak. We can then obtain the complete forms of Raman tensors under a magnetic field, considering the crystal symmetry and the magnetic field influence together. The refined Raman tensor is represented in the following form as

$$\begin{aligned} \chi_{A'}(C_{3h}, B=0) &= \begin{pmatrix} a & c & 0 \\ -c & a & 0 \\ 0 & 0 & b \end{pmatrix} \rightarrow \chi_{A'}(C_{3h}, B \neq 0) \\ &= \begin{pmatrix} \alpha_{xx}(B) \cdot a & \alpha_{yx}(B) \cdot c & 0 \\ -\alpha_{xy}(B) \cdot c & \alpha_{yy}(B) \cdot a & 0 \\ 0 & 0 & b \end{pmatrix}. \end{aligned} \quad (6)$$

The polarization-resolved Raman intensity of the  $A'$  modes can finally be derived as

$$I_s \propto (a \cos \varphi)^2 \rightarrow I_s \propto \left| a \frac{B_0}{B_0^2 + B^2} \cos \varphi + c \frac{B}{B_0^2 + B^2} \sin \varphi \right|^2 \quad (7)$$

Since the integrated intensities of Raman modes rely on numerous factors, including excitation power density, integral time, and collection efficiency, the absolute values of the Raman tensor elements,  $a$  and  $c$ , make no great sense. By exploiting eqn (7) to fit the polarization-dependence in Fig. 3a–k, we obtained the value of  $|B_0| = 3.25 \pm 0.23$  T, where the influence from the magnetic field on the polarization-resolved optical signal intensity approaches the maximum. It should be pointed out that if the magnetic field  $B$  reaches very high, the influence of Landau levels (LLs,  $\hbar\omega_c = \hbar eB/m^*$ ) will become non-neglected (ESI, Fig. S5†). In short, the emergence of LLs with high degeneracy under magnetic fields will subtly modify the original band structures and perhaps remarkably affect the optical transitions, which may result in a Raman resonance if the allowed optical transition energetically matches LLs. In magneto-optical measurements, the magnetic field induces a beam deflection for light beams traversing along the magnetic field due to the Faraday effect, which can also be called Faraday rotation.<sup>43,44</sup> We determined this Faraday rotation to be  $-1.09^\circ \text{ T}^{-1}$  (ESI Fig. S6†) in our measurement system by analyzing the linearly polarized scattering light rotation on bare Si/SiO<sub>2</sub> substrates under various magnetic fields. The polarization

angle where the maximum of MoS<sub>2</sub>  $A'$  mode lies versus the perpendicular magnetic field strength is plotted in Fig. 3l, where the Faraday rotation has already been compensated.

We also performed the magneto-PL measurements on the MoS<sub>2</sub> monolayer<sup>45–48</sup> (see the experimental set-up in ESI, Fig. S7†). The circular polarized magneto-PL spectra were recorded under a resonant excitation wavelength of 633 nm (HeNe laser). The selection of the excitation wavelengths is very important (ESI, Fig. S8†). The magnetic field is still applied perpendicularly to the MoS<sub>2</sub> sample  $c$ -plane. The circular polarization-resolved PL spectra (obtained at  $B = -5$  T, 0 T, and +5 T) of the MoS<sub>2</sub> monolayer on the Si/SiO<sub>2</sub> substrate are shown in Fig. 4a. The left circularly polarized ( $\sigma^+$ ) light couples to the K valley, and the right circularly polarized ( $\sigma^-$ ) light couples to the K' valley. The A excitonic transition energies are extracted by the Lorentzian line shape fitting. For the MoS<sub>2</sub> monolayer on Si/SiO<sub>2</sub> at  $B = 0$  T (Fig. 4a, middle plot), the ( $\sigma^+ \rightarrow \sigma^+$ ) and ( $\sigma^- \rightarrow \sigma^-$ ) PL spectra, where the excited and the detected light with the same chirality, are identical with each other, indicating no energy splitting in these two sets of degenerate-but-inequivalent valleys, required by the time-reversal symmetry. The A excitonic energy is extracted to be 1.82 eV, similar to the previously reported value. In contrast, under a negative magnetic field ( $-5$  T), a small valley splitting can be discerned (Fig. 4a, top plot). The A excitonic transition at the K valley, corresponding to the ( $\sigma^+ \rightarrow \sigma^+$ ) spectrum, shifts to a higher photon energy, whereas that at the K' valley, corresponding to the ( $\sigma^- \rightarrow \sigma^-$ ) spectrum, shifts to a lower photon energy. The valley splitting is calculated and defined as the equation,  $\Delta \equiv E(\sigma^+) - E(\sigma^-)$ , where  $E(\sigma^+)$  and  $E(\sigma^-)$  represent the fitting peak energies in ( $\sigma^+ \rightarrow \sigma^+$ ) and ( $\sigma^- \rightarrow \sigma^-$ ) spectra, respectively. For the MoS<sub>2</sub> monolayer,  $\Delta$  is +1.18 meV at  $-5$  T, in agreement with the previously reported value. The valley splitting  $\Delta$  changes sign and has a value of  $-1.05$  meV at +5 T (Fig. 4a, bottom plot).

The origin for Zeeman splitting in the MoS<sub>2</sub> monolayer can be understood by studying the contribution of the spin, valley, and

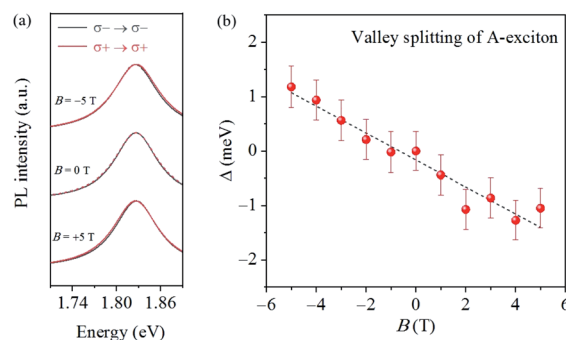


Fig. 4 (a) Normalized polarization-resolved PL spectra under the 0 and  $\pm 5$  T magnetic fields. The circular polarized magneto-PL spectra were measured, under resonant excitation wavelength of 633 nm (HeNe laser). The  $\sigma^-$  and  $\sigma^+$  polarization-resolved spectra almost completely overlap in absence of magnetic field (0 T), and they split inversely under positive and negative magnetic fields ( $\pm 5$  T). (b) Valley splitting ( $\Delta$ ) versus the magnetic field strength. For MoS<sub>2</sub> monolayer on Si/SiO<sub>2</sub> substrate,  $\Delta$  changes with the magnetic field strength monotonously, with a linear slope of  $\sim -0.24 \text{ meV T}^{-1}$ .

atomic orbital magnetic moments to the electronic energy levels at K and K' valleys. Given the time-reversal symmetry in the absence of magnetic field (0 T), the energies of electrons at K and K' valleys are intrinsically degenerate. In the presence of a perpendicular magnetic field ( $B \perp c$ -plane), this degeneracy is broken, resulting in an energy splitting between the two K and K' valleys due to the Zeeman effect. The detailed description is provided in the ESI, Fig. S9.† To elucidate the field-induced Zeeman splitting, we plot the field-dependent valley Zeeman splitting  $\Delta$  in Fig. 4b. For the MoS<sub>2</sub> monolayer,  $\Delta$  increases with the magnetic field at a linear slope of  $-0.24 \pm 0.02$  meV T<sup>-1</sup>. The observed valley splitting can be expressed as  $g\mu_B B$ , where  $\mu_B$  means the Bohr magneton, extracting the effective  $g$  factor to be  $4.14 \pm 0.17$ , in agreement with reported values previously obtained from the differential reflection spectra.<sup>47</sup> However, as we can see from Fig. 4b, not only the value of the polarization-resolved photon energy splitting on the scale of milli electron-volt is very small but also the value error is considerable. This magnetic field-induced Zeeman splitting effect is much weaker than the observed Raman scattering rotation under the same measurement conditions. In contrast, Raman spectroscopy provides a more feasible and sensitive probe for exploring the magneto-optical effect induced by external perturbations.

## Conclusions

In summary, we have successfully conducted polarization-resolved micro-zone Raman and PL spectroscopy investigation on the non-magnetic MoS<sub>2</sub> monolayer in the presence of magnetic fields. The relationship between the A-mode and the polarization angle between the excited and scattered lights can be efficiently modulated by the perpendicular magnetic field. A gigantic linearly polarized inelastically scattered light rotation ( $\sim 125^\circ$ ) as well as the modest Zeeman splitting ( $\sim 1.2$  meV) were observed. The experimental observation results and analysis reveal the mechanism of the magneto-Raman effect in MoS<sub>2</sub>, which is related to the behavior of electron motion in the presence of a perpendicular magnetic field, originating from the symmetry breaking induced by the external field, which dominates the electron motion during the scattering process. Such a tremendous magneto-optical effect at a monolayer scale and the underlying technological potentials for novel magneto-optical devices should arouse a new ramification of the research upon the inelastic scattering light. Our findings demonstrate the ultrathin vdWs materials as a unique platform for investigating numerous ground-breaking magneto-optical effects, which are sensitive to external perturbations.

## Methods

### Material preparation

Monolayer MoS<sub>2</sub> was synthesized on 285 nm Si/SiO<sub>2</sub> substrates via the CVD method inside a two-zone tube furnace using S (99.999%) and MoO<sub>3</sub> (99.99%) powders as the solid-state precursors, PTAS organics as the seeding promoter by catalyzing reduced metal oxides onto substrate surfaces, and high-purity Ar as the transport gas.

### Sample characterization

The detailed morphology of MoS<sub>2</sub> was investigated by AFM (Cypher S, Asylum Research). The room-temperature polarization-dependent Raman spectra of MoS<sub>2</sub> were collected on a commercial Raman confocal system (Alfa300R, WITec) excited by a 2.33 eV (532 nm) laser and dispersed by a spectrometer equipped with a diffraction grating of 1800 grooves per mm. The excitation beam was focused onto the sample surface by a 100 $\times$  objective lens. The emitted and scattered lights were collected by the same lens. The PL and Raman spectroscopy mapping images were captured by the same system.

### Magneto-Raman measurement

The magneto-Raman spectra were captured by a home-built optical measurement system in the Faraday geometry based on a closed-cycle helium cryostat (attoDRY2100, attocube). The perpendicular magnetic fields of  $\pm 5$  T were generated and applied by the superconducting solenoidal magnet around the vacuum cryostat. The 2.33 eV excitation laser spot of 3  $\mu$ m diameter was focused at normal incidence onto the sample surface by a 50 $\times$  objective lens. In magneto-Raman measurements, the optical signals were dispersed by a spectrometer (Andor SR500) equipped with a diffraction grating of 1200 groove/mm and a slit of 10  $\mu$ m, enabling the wavelength resolution  $< 0.1$  nm with a 25  $\mu$ m pixel charge-coupled device (CCD) detector. In consideration of the thermal conduction and the stability of the superconducting magnets, all the magneto-optical spectra in this study were taken at 270 K, slightly lower than room temperature.

## Conflicts of interest

The authors declare no competing financial interest.

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